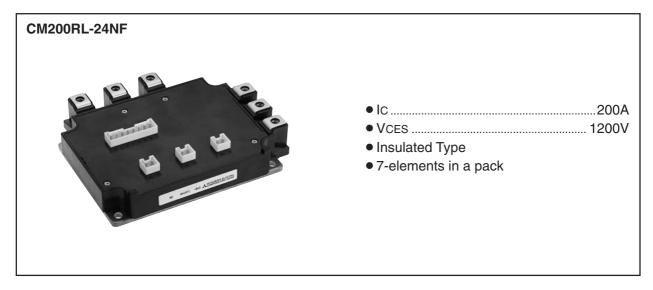
MITSUBISHI IGBT MODULES

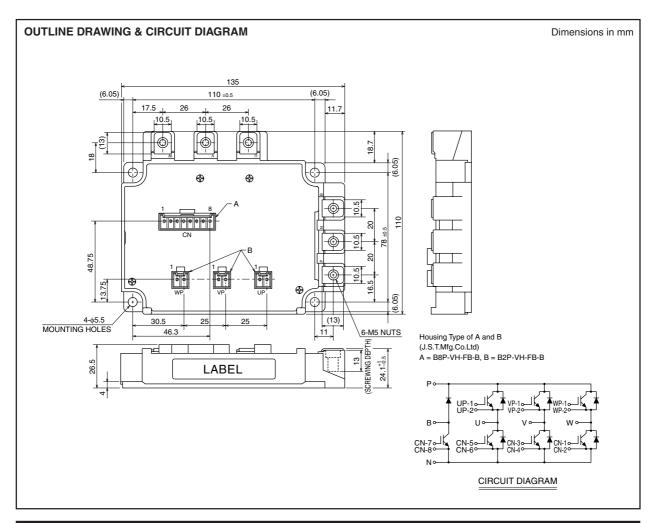
CM200RL-24NF

HIGH POWER SWITCHING USE



APPLICATION

AC drive inverters & Servo controls, etc





HIGH POWER SWITCHING USE

ABSOLUTE MAXIMUM RATINGS (Tj = 25° C, unless otherwise specified) INVERTER PART

Symbol	Parameter	Conditions		Ratings	Unit
VCES	Collector-emitter voltage	G-E Short		1200	V
VGES	Gate-emitter voltage	C-E Short		±20	V
Ic	0-114	DC, $Tc = 72^{\circ}C^{*1}$		200	Α
Ісм	Collector current	Pulse	(Note 2)	400	Α
IE (Note 1)	Emitter current			200	Α
IEM (Note 1)		Pulse	(Note 2)	400	Α
PC (Note 3)	Maximum collector dissipation	Tc = 25°C	-	1160	W

BRAKE PART

Symbol	Parameter	Conditions	Ratings	Unit
VCES	Collector-emitter voltage	G-E Short	1200	V
VGES	Gate-emitter voltage	C-E Short	±20	V
Ic	0-11	DC, $Tc = 80^{\circ}C^{*1}$	100	Α
Ісм	Collector current	Pulse (Note 2)	200	Α
PC (Note 3)	Maximum collector dissipation	Tc = 25°C	620	W
VRRM	Repetitive peak reverse voltage	Clamp diode part	1200	V
IFМ	Forward current	Clamp diode part	100	Α

(COMMON RATING)

Symbol	Parameter	Conditions	Ratings	Unit
Tj	Junction temperature		-40 ~ +150	°C
Tstg	Storage temperature		-40 ~ +125	°C
Viso	Isolation voltage	Terminals to base plate, f = 60Hz, AC 1 minute	2500	Vrms
_	Torque strength	Main terminals M5 screw	2.5 ~ 3.5	N•m
_	Torque strength	Mounting M5 screw	2.5 ~ 3.5	N•m
_	Weight	Typical value	750	g



HIGH POWER SWITCHING USE

ELECTRICAL CHARACTERISTICS (Tj = 25°C, unless otherwise specified) **INVERTER PART**

0	Dougeneter	neter Test conditions		Limits			Unit
Symbol	Parameter			Min.	Тур.	Max.	Unit
ICES	Collector cutoff current	VCE = VCES, VGE = 0V		_	_	1	mA
VGE(th)	Gate-emitter threshold voltage	IC = 20mA, VCE = 10V		6	7	8	V
IGES	Gate leakage current	±VGE = VGES, VCE = 0V		_	_	0.5	μΑ
	0 11 11 11 11	T _i = 25°C		_	2.1	3.1	
VCE(sat)	Collector-emitter saturation voltage	IC = 200A, VGE = 15V	Tj = 125°C	_	2.4	_	V
Cies	Input capacitance	101		_	_	35	nF
Coes	Output capacitance	VCE = 10V VGE = 0V		_	_	3	nF
Cres	Reverse transfer capacitance				_	0.68	nF
QG	Total gate charge	Vcc = 600V, Ic = 200A, VgE = 15V		_	1000	_	nC
td(on)	Turn-on delay time	Vcc = 600V, Ic = 200A		_	_	130	ns
tr	Turn-on rise time			_	_	70	ns
td(off)	Turn-off delay time	VGE = ±15V		_	_	400	ns
tf	Turn-off fall time	$RG = 1.6\Omega$, Inductive load		_	_	350	ns
trr (Note 1)	Reverse recovery time	IE = 200A		_	_	150	ns
Qrr (Note 1)	Reverse recovery charge			_	9	_	μС
VEC(Note 1)	Emitter-collector voltage	IE = 200A, VGE = 0V		_	_	3.8	V
Rth(j-c)Q	IGBT part (1/6 module)*1		_	_	0.11	K/W	
Rth(j-c)R	Thermal resistance	FWDi part (1/6 module)*1		_	_	0.17	K/W
Rth(c-f)	Contact thermal resistance	Case to heat sink, Thermal compound Applied (1/6 module)*2		_	0.051	_	K/W
RG	External gate resistance			1.6	_	21	Ω

BRAKE PART

	Parameter	Test conditions		Limits			
Symbol				Min.	Тур.	Max.	Unit
ICES	Collector cutoff current	VCE = VCES, VGE = 0V	VCE = VCES, VGE = 0V		_	1	mA
VGE(th)	Gate-emitter threshold voltage	IC = 10mA, VCE = 10V		6	7	8	V
IGES	Gate leakage current	±VGE = VGES, VCE = 0V		_	_	0.5	μΑ
VCE(sat)	Collector-emitter saturation voltage	IC = 100A, VGE = 15V	Tj = 25°C	_	2.1	3.0	V
			Tj = 125°C	_	2.4	_	
Cies	Input capacitance	\/o= 40\/		_	_	17.5	nF
Coes	Output capacitance	VCE = 10V VGE = 0V		_	_	1.5	nF
Cres	Reverse transfer capacitance			_	_	0.34	nF
QG	Total gate charge	VCC = 600V, IC = 100A, VGE = 15V		-	500	-	nC
VFM	Forward voltage drop	IF = 100A		T —	_	3.8	V
Rth(j-c)Q	Thormal registance	Thermal resistance IGBT part*1 Clamp diode part*1		_	_	0.20	K/W
Rth(j-c)R	Theimariesistance			_	_	0.28	K/W
Rg	External gate resistance			3.1	_	31	Ω

Note 1. IE, VEC, trr & Qrr represent characteristics of the anti-parallel, emitter-collector free-wheel diode (FWDi).

- Pulse width and repetition rate should be such that the device junction temperature (Tj) does not exceed T_{jmax} rating.
 Junction temperature (Tj) should not increase beyond 150°C.
 Pulse width and repetition rate should be such as to cause negligible temperature rise.

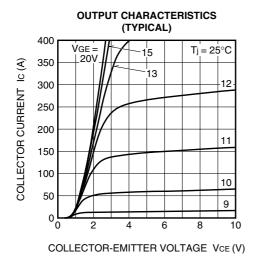


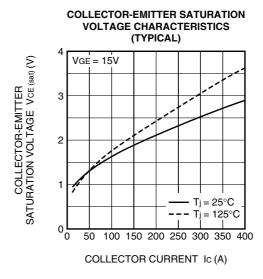
Feb. 2009

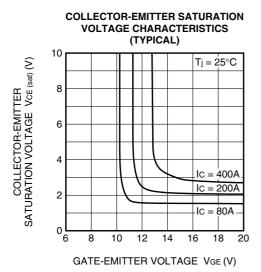
^{*1 :} Case temperature (Tc) measured point is just under the chips.
If you use this value, Rth(f-a) should be measured just under the chips.
*2 : Typical value is measured by using thermally conductive grease of λ = 0.9[W/(m • K)].

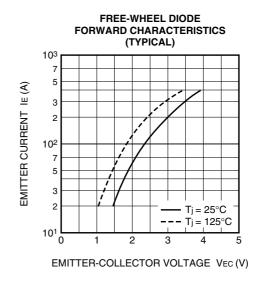
HIGH POWER SWITCHING USE

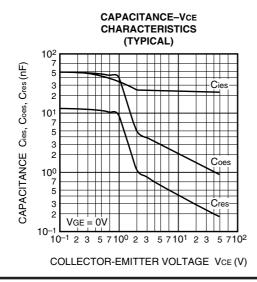
PERFORMANCE CURVES

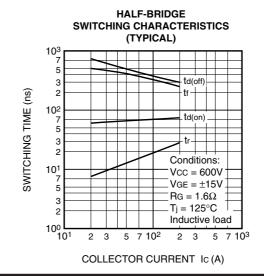














Feb. 2009

HIGH POWER SWITCHING USE

REVERSE RECOVERY CHARACTERISTICS OF FREE-WHEEL DIODE (TYPICAL) 10³ REVERSE RECOVERY CURRENT In (A) REVERSE RECOVERY TIME trr (ns) 5 3 Irr 2 10² 7 Conditions: 5 Vcc = 600V $VGE = \pm 15V$ 3 $RG = 1.6\Omega$ 2 $T_i = 25^{\circ}C$ Inductive load 101 L 101

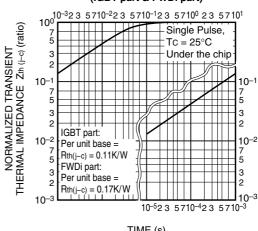
2 3 5 7 102

EMITTER CURRENT IE (A)

5 7 103

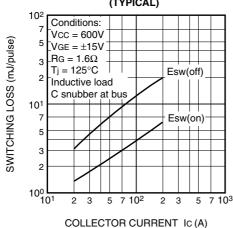
3

TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (IGBT part & FWDi part)

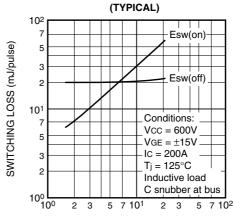


TIME (s)

SWITCHING LOSS vs. **COLLECTOR CURRENT** (TYPICAL)



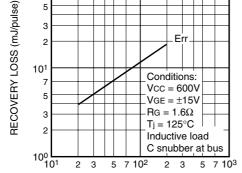
SWITCHING LOSS vs. **GATE RESISTANCE**



GATE RESISTANCE RG (Ω)

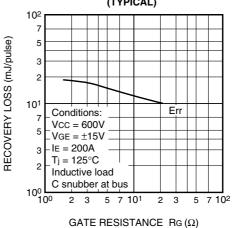
(TYPICAL) 10² 5 3

RECOVERY LOSS vs. IE



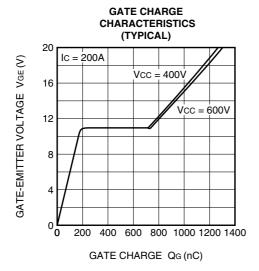
EMITTER CURRENT IE (A)

RECOVERY LOSS vs. GATE RESISTANCE (TYPICAL)





HIGH POWER SWITCHING USE





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